Notice of References Cited					Application/Control No. 10/661,228		Reexaminatio	Applicant(s)/Patent Under Reexamination SPAETH ET AL.	
					Examiner		Art Unit		
					EDWYN LA	BAZE	2876	Page 1 of 1	
U.S. PATENT DOCUMENTS									
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name Classification					
*	Α	US-2002/0010757	01-2002	Granik et al.				709/218	
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FOREIGN PATENT DOCUMENTS									
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